



# KOPPLUNG HOCHFREQUENTER SIGNALE AUF DER LEITERPLATTE

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Field Application Engineers

**WÜRTH ELEKTRONIK** MORE THAN YOU EXPECT

- Kopplung zwischen Stromkreisen
  - Kopplungsarten
  - Messungen mit Nahfeldsonden
  
- Schirmanbindung
  - Pfade hochfrequenter Ströme
  - Impedanz des Rückstrompfades
  - Messung des Magnetfeldes der Leiterschleife



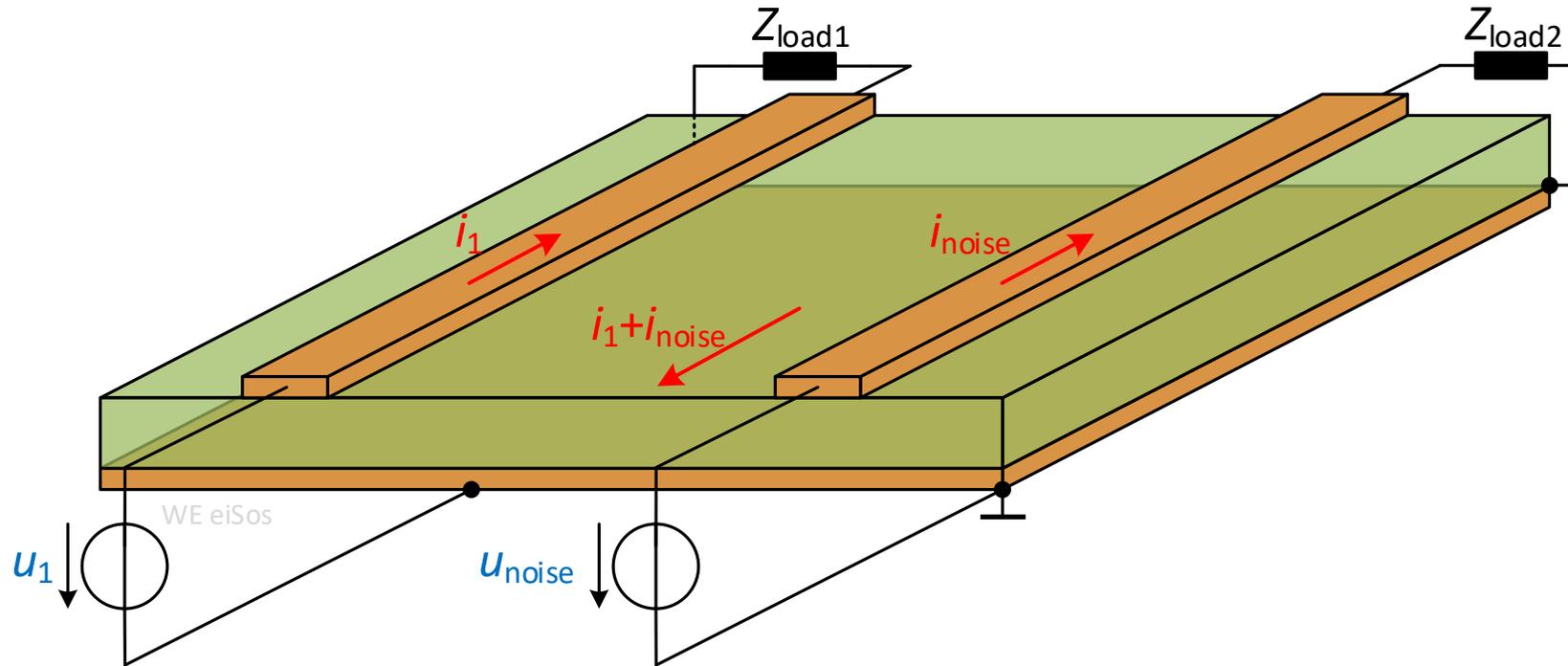
# Kopplung zwischen Stromkreisen

Kopplungsarten

Messungen mit Nahfeldsonden

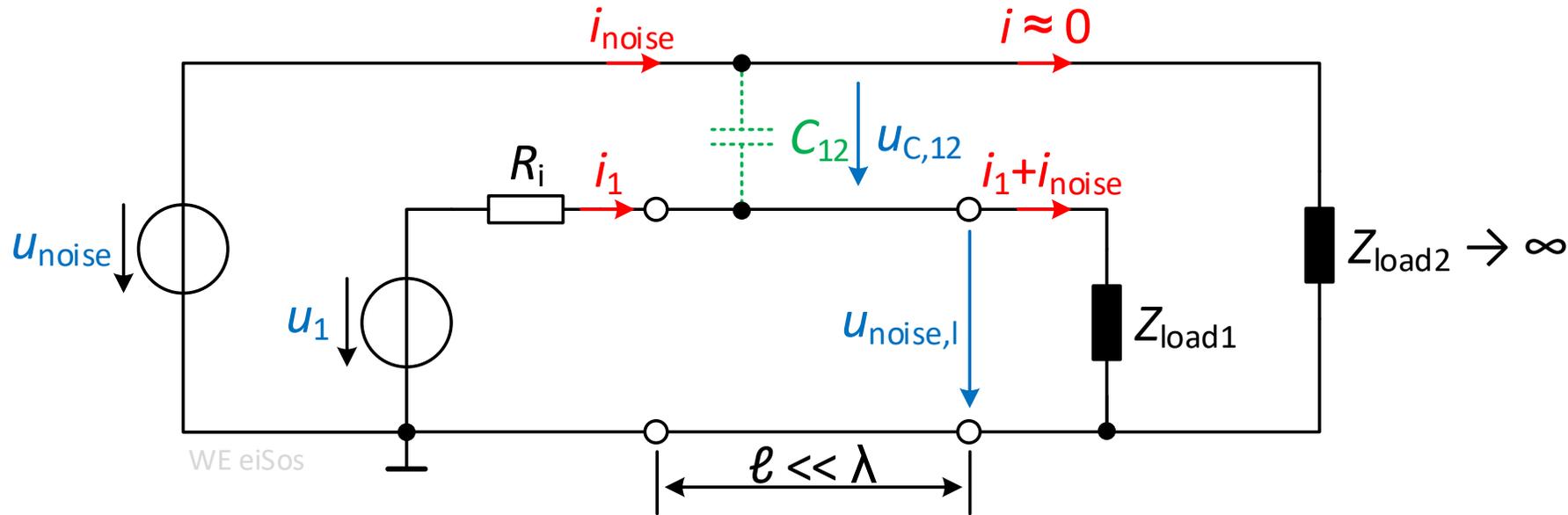
# Coupling effects

## Overview



- Dominant **capacitive** coupling when  $Z_{load,2} \rightarrow \infty$
- Dominant **inductive** coupling when  $Z_{load,2} \rightarrow 0$
- **Impedance coupling** when they have the same common return (Ground plane)

# Kapazitive Kopplung



- Annahme und Vereinfachung:  $X_{C_{12}} \gg R_i \parallel Z_{\text{load},1} \Rightarrow u_{C_{12}} \gg u_{\text{noise},l} \Rightarrow u_{C_{12}} \sim u_{\text{noise}}$
- Störspannung an der Last:

$$u_{\text{noise},l} = i_{\text{noise}} \cdot \frac{R_i \cdot Z_{\text{load},1}}{R_i + Z_{\text{load},1}} = C_{12} \cdot \frac{du_{\text{noise}}}{dt} \cdot \frac{R_i \cdot Z_{\text{load},1}}{R_i + Z_{\text{load},1}}$$

# Kapazitive Kopplung

- Beispiel:

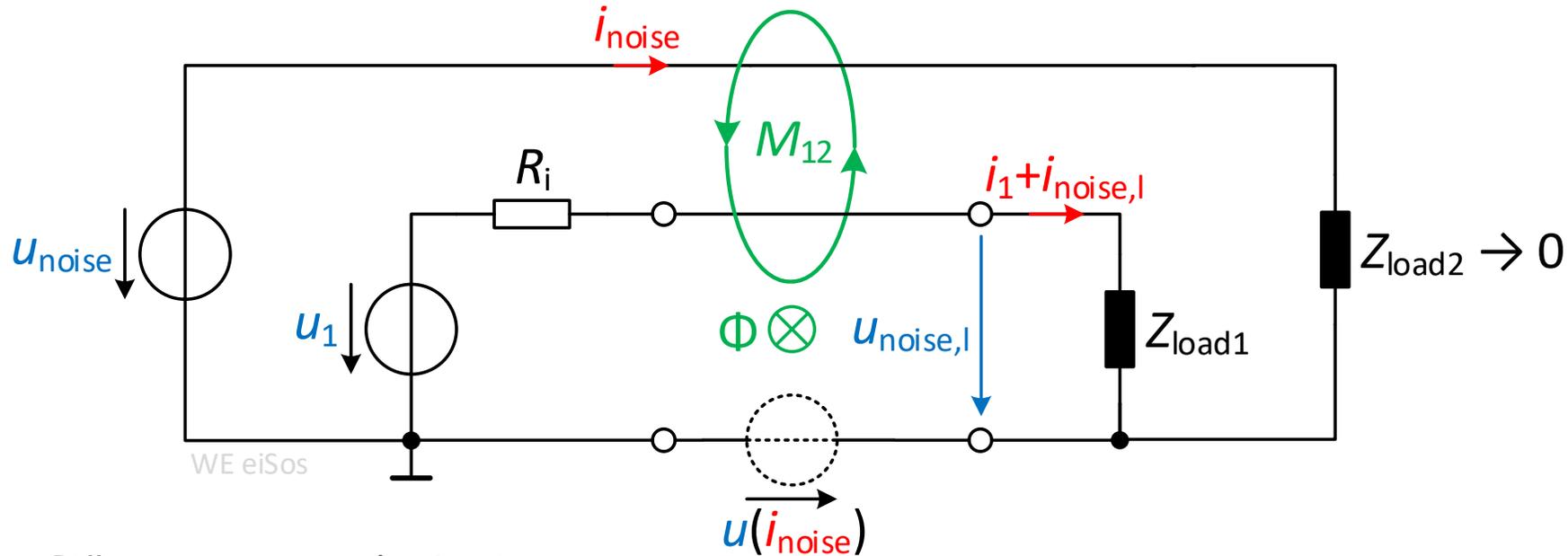
- 2 parallele Mikrostreifenleitungen mit 2mm Breite, 50mm Länge und einem Abstand von 2mm ( $\epsilon_r = 2,4$ )  
→  $C_{12} = 1,7\text{pF}$
- Schaltflanke eines MOSFET:
- $R_i = 10\text{m}\Omega$ ,  $Z_{\text{load},1} = 5\Omega$
- $U_1 = 5\text{V} \rightarrow U_{\text{load},1} = 4,99\text{V}$
- Störspannung:

- Signal-Rausch-Abstand:

$$u_{\text{noise},l} = C_{12} \cdot \frac{du_{\text{noise}}}{dt} \cdot \frac{R_i \cdot Z_{\text{load},1}}{R_i + Z_{\text{load},1}} = 17\mu\text{V}$$

$$\text{SNR} = 20 \cdot \log\left(\frac{4,99\text{V}}{17\mu\text{V}}\right) = 109,4\text{dB}$$

# Induktive Kopplung



- Störspannung an der Last:

$$u_{\text{noise},l} = u(i_{\text{noise}}) \cdot \frac{Z_{\text{load},1}}{R_i + Z_{\text{load},1}} = M_{12} \cdot \frac{di_{\text{noise}}}{dt} \cdot \frac{Z_{\text{load},1}}{R_i + Z_{\text{load},1}}$$

# Induktive Kopplung

- Beispiel:

- 2 parallele Kabel ( $\emptyset$  5mm), 10cm über einer leitfähigen Ebene, mit einem Abstand von 10cm über eine Länge von 10m  $\rightarrow M_{12} = 1,61\mu\text{H}$
- Änderungsrate des Stromes durch die induktive Last  $Z_{\text{load},2}$ :
- $R_i = 10\text{m}\Omega$ ,  $Z_{\text{load},1} = 1\Omega$
- $U_1 = 24\text{V} \rightarrow U_{\text{load},1} = 23,76\text{V}$
- Störspannung:

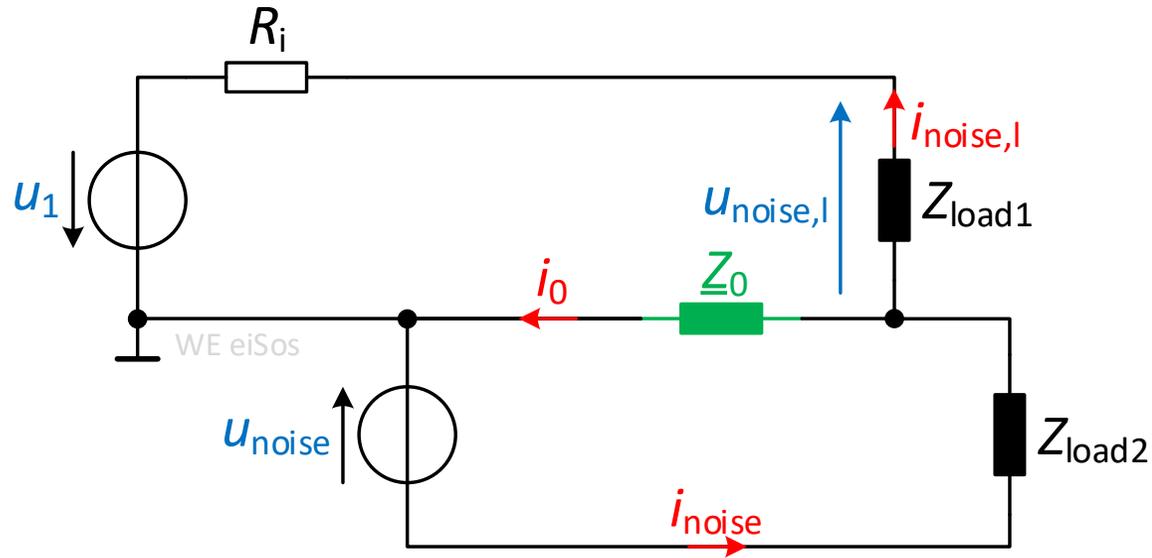
$$\frac{di_{\text{noise}}}{dt} = 2 \frac{\text{A}}{\mu\text{s}}$$

- Signal-Rausch-Abstand:

$$u_{\text{noise},1} = M_{12} \cdot \frac{di_{\text{noise}}}{dt} \cdot \frac{Z_{\text{load},1}}{R_i + Z_{\text{load},1}} = 3,19\text{V}$$

$$\text{SNR} = 20 \cdot \log\left(\frac{23,76\text{V}}{3,19\text{V}}\right) = 17,45\text{dB}$$

# Impedanzkopplung

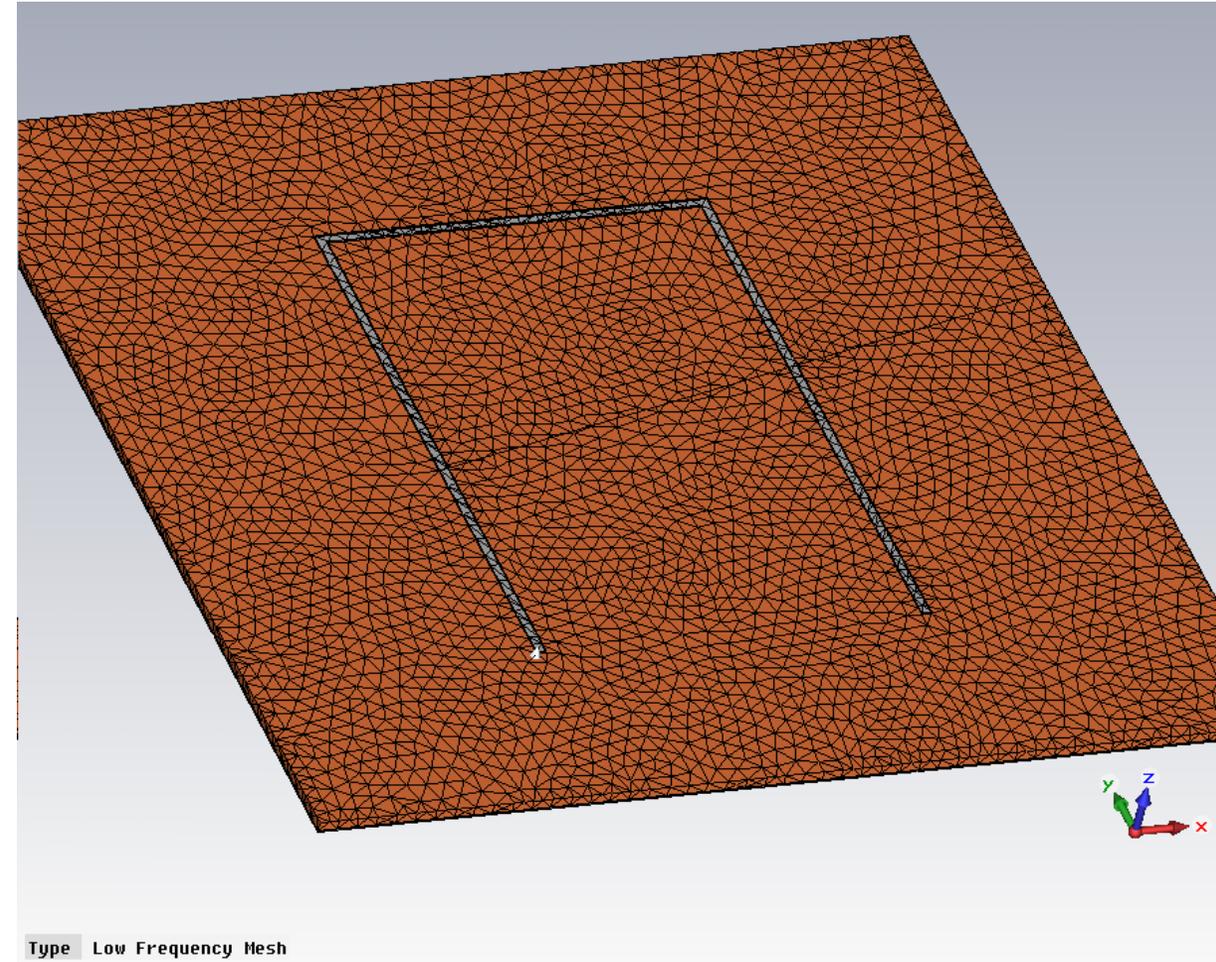
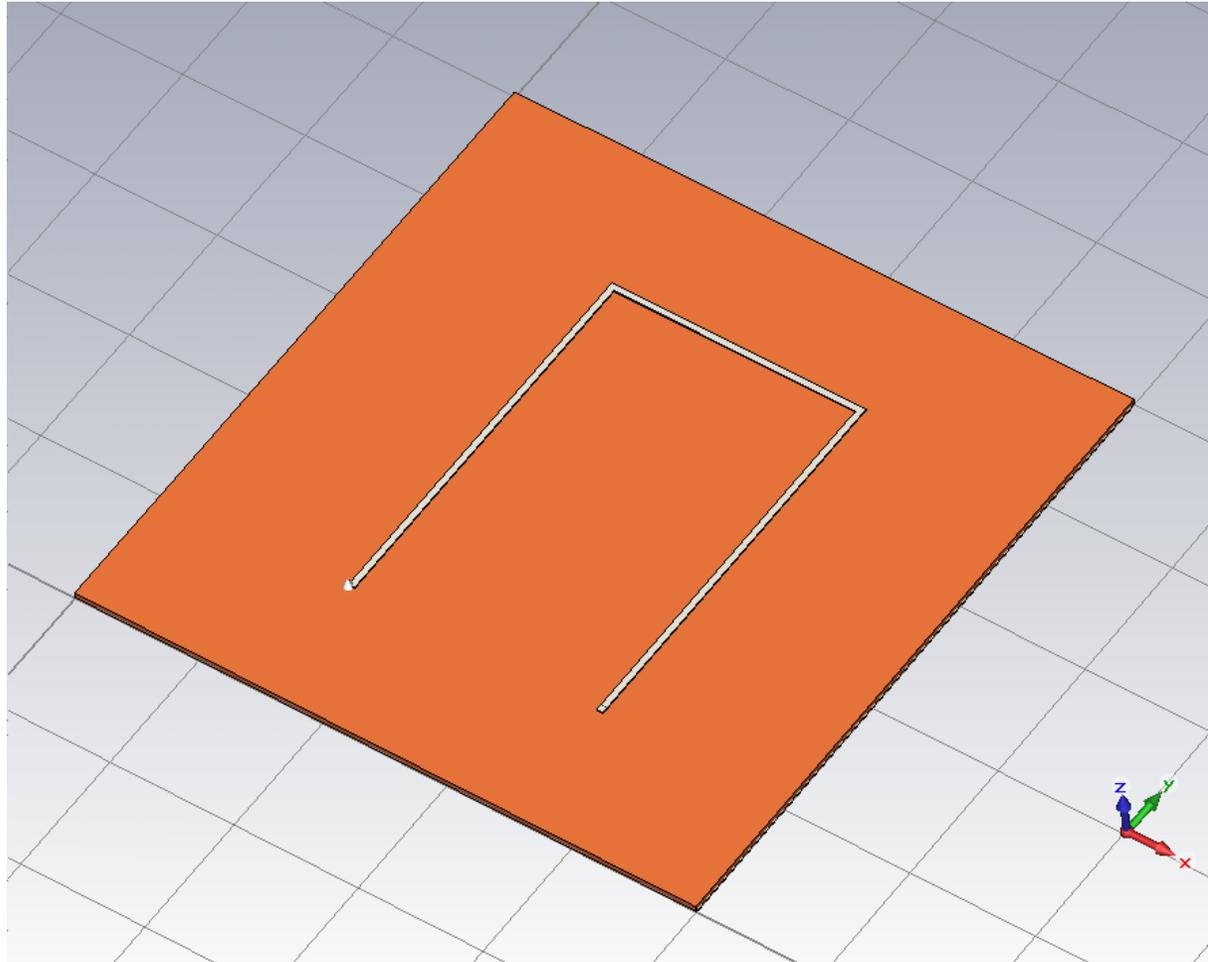


- Koppelimpedanz:  $\underline{Z}_0 = R_0 + j\omega L_0$
- Störspannung an der Last:

$$u_{\text{noise},l} = \frac{u_{\text{noise}}}{Z_{\text{load},2} + (R_i + Z_{\text{load},1}) \parallel \underline{Z}_0} \cdot \frac{Z_{\text{load},1} \cdot \underline{Z}_0}{R_i + Z_{\text{load},1} + \underline{Z}_0}$$

# Coupling effects

Simulation in CST EMS



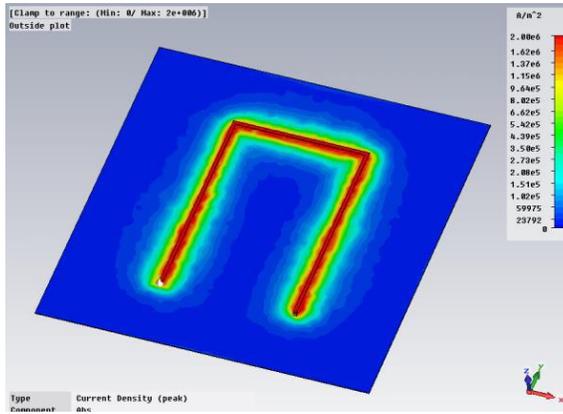
Type Low Frequency Mesh

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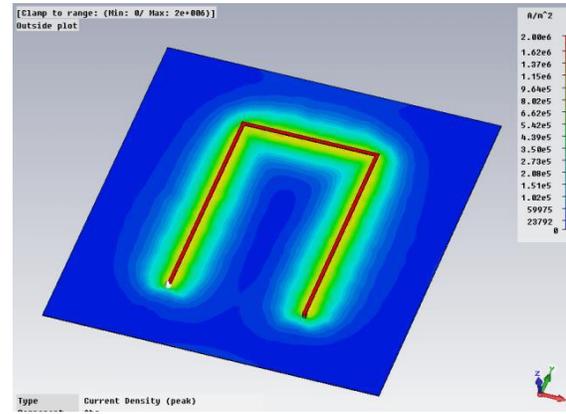
# Coupling effects

Current path with a u shaped conductor simulated in CST EMS

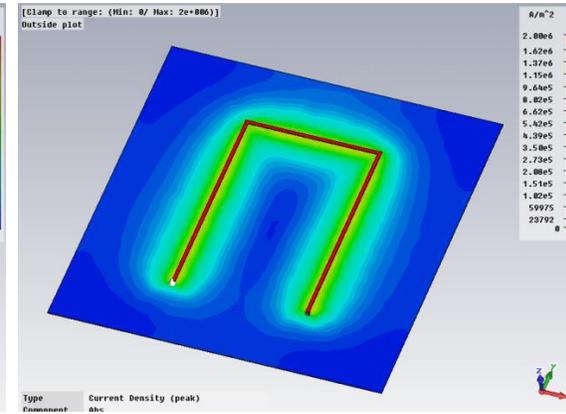
100kHz



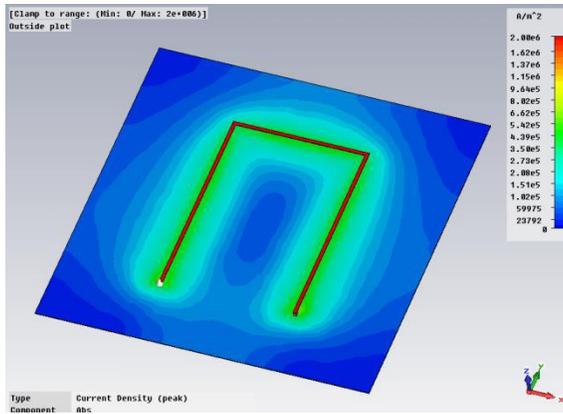
10kHz



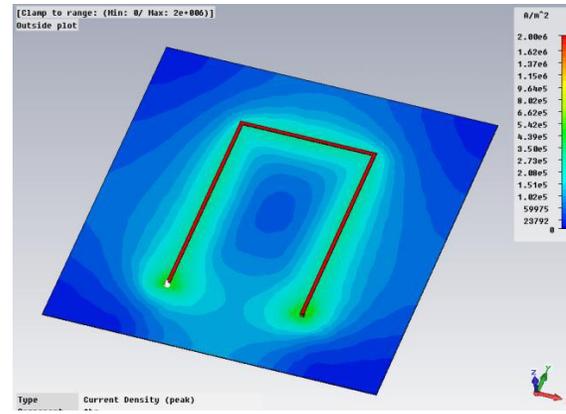
5kHz



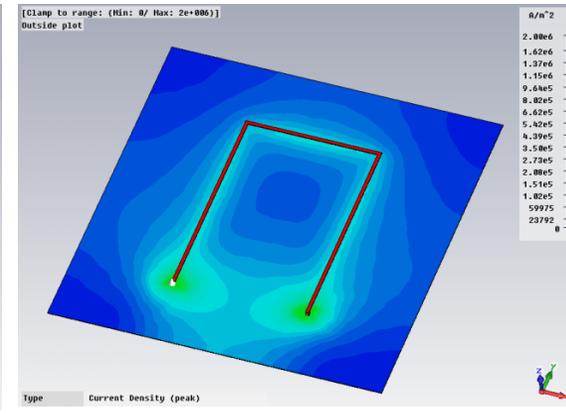
2kHz



1kHz



500Hz

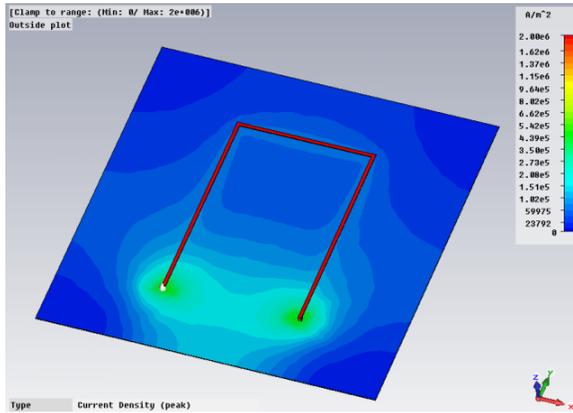


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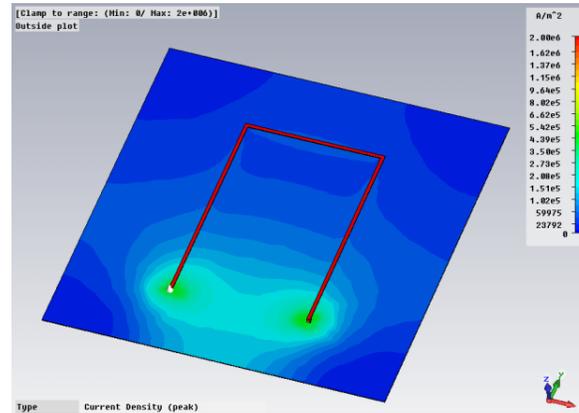
# Coupling effects

Current path with a u shaped conductor simulated in CST EMS

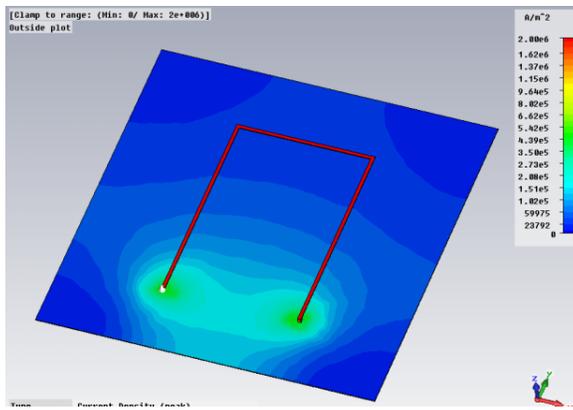
200Hz



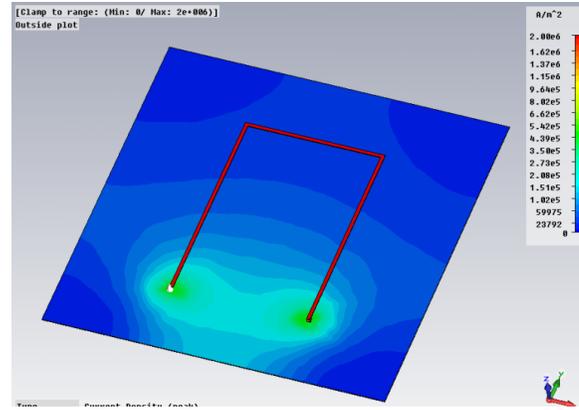
100Hz



50Hz



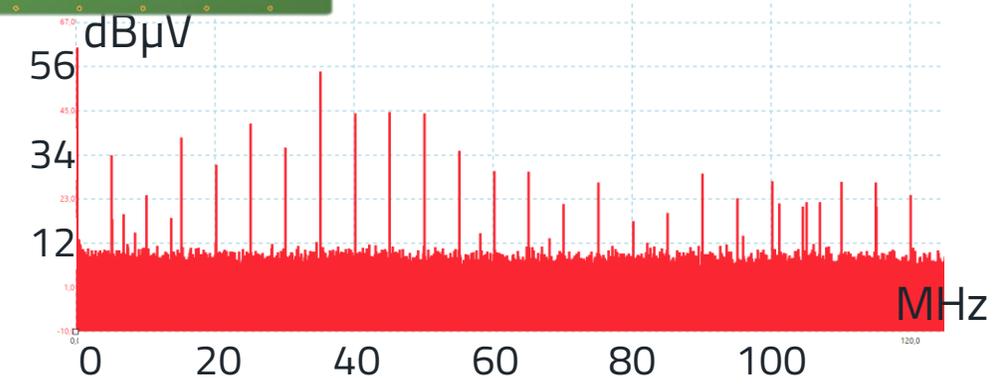
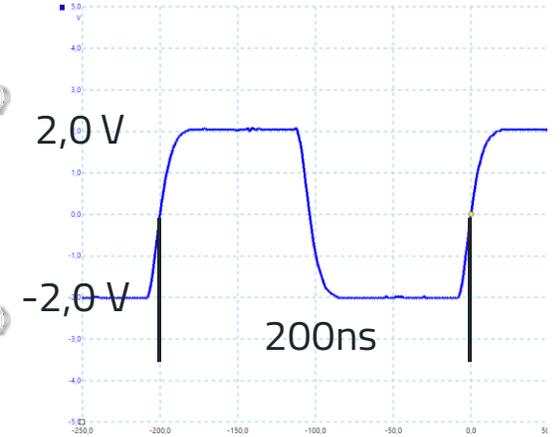
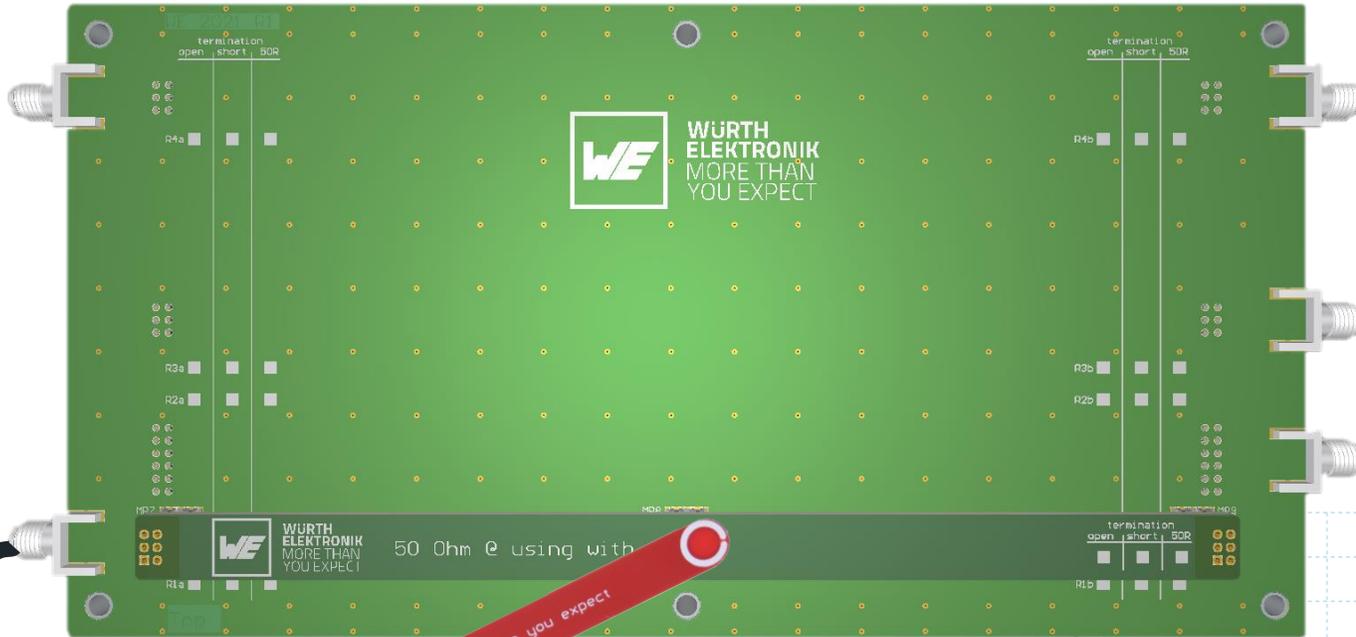
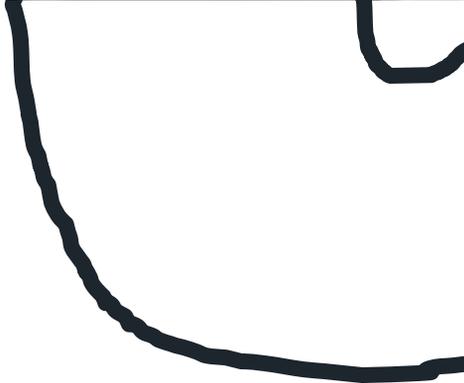
10Hz



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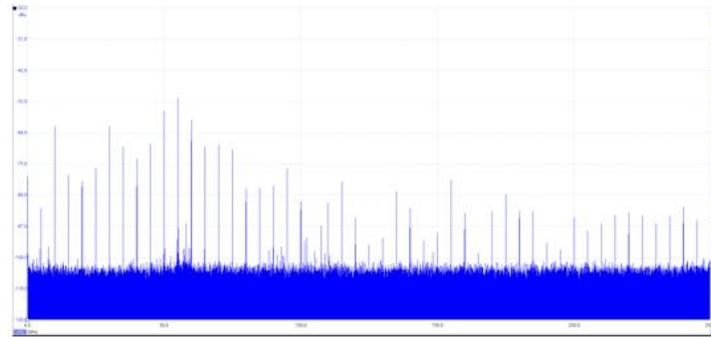
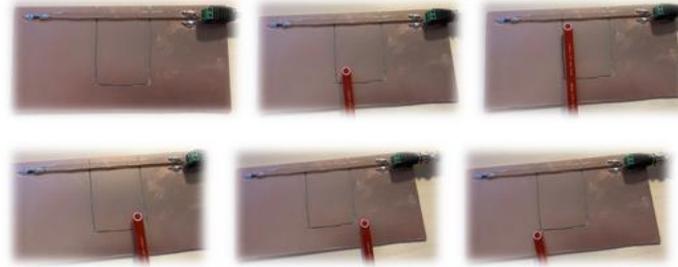
# Coupling effects

Return path of high frequency current

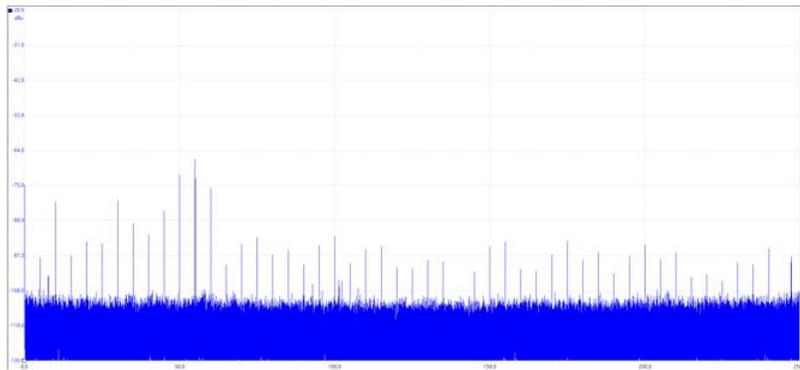


# Coupling effects

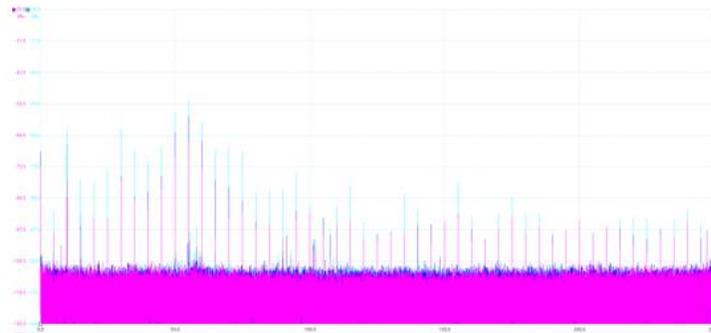
Return path of high frequency current



Ca. 52dB. ... Verschlechterung um ca. 15dB, im gesamten Bereich der Freistellung Vergleich

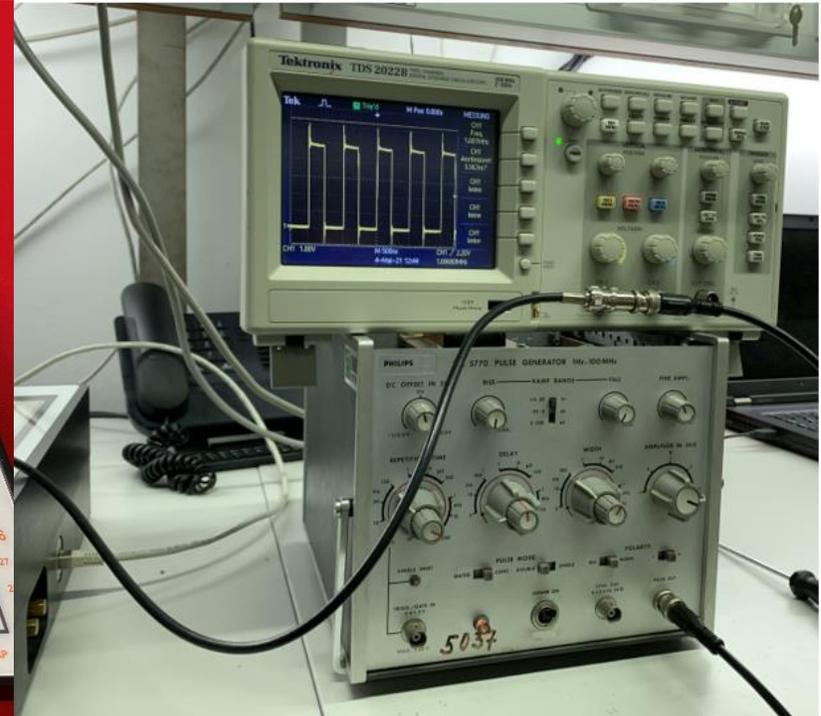
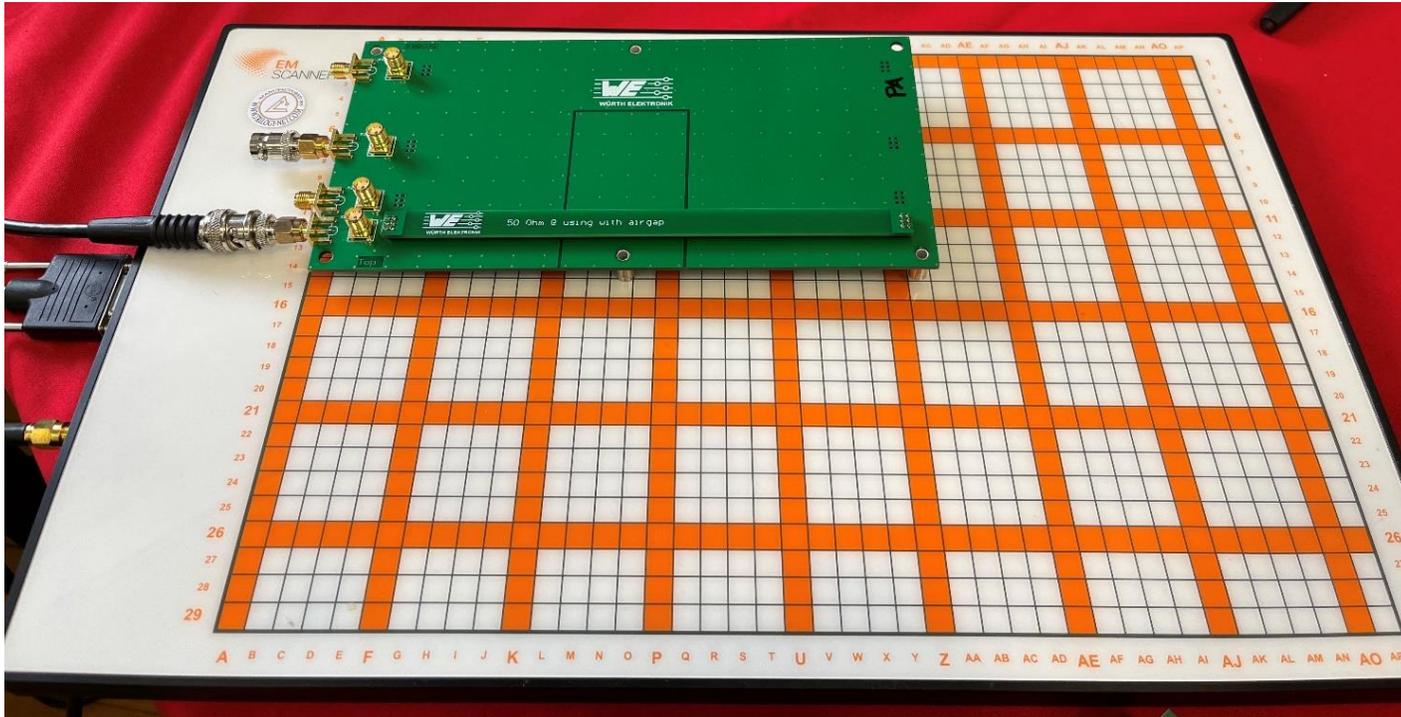


... ca. -67dB



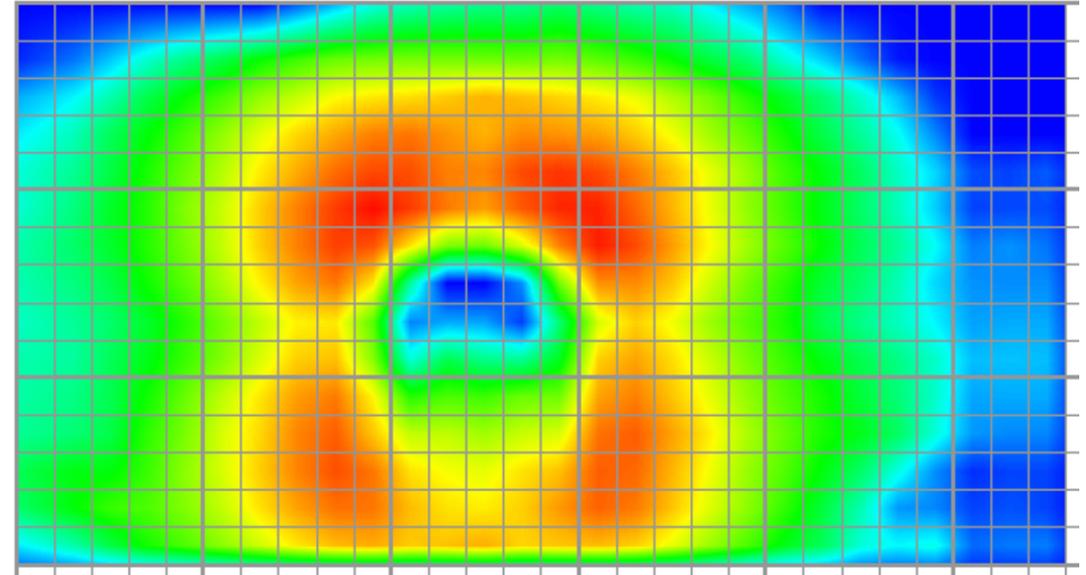
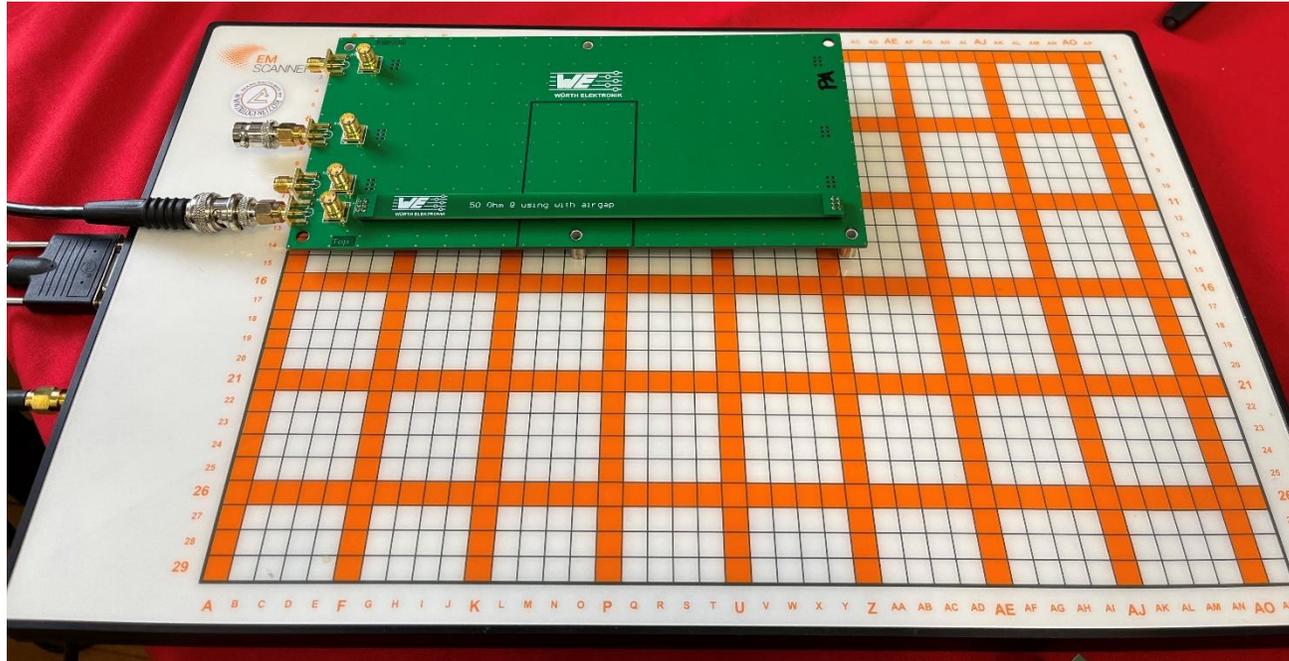
# Coupling effects

Return path of high frequency current



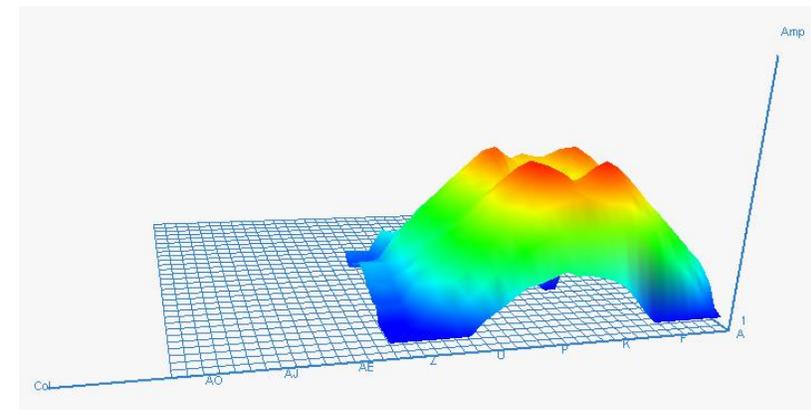
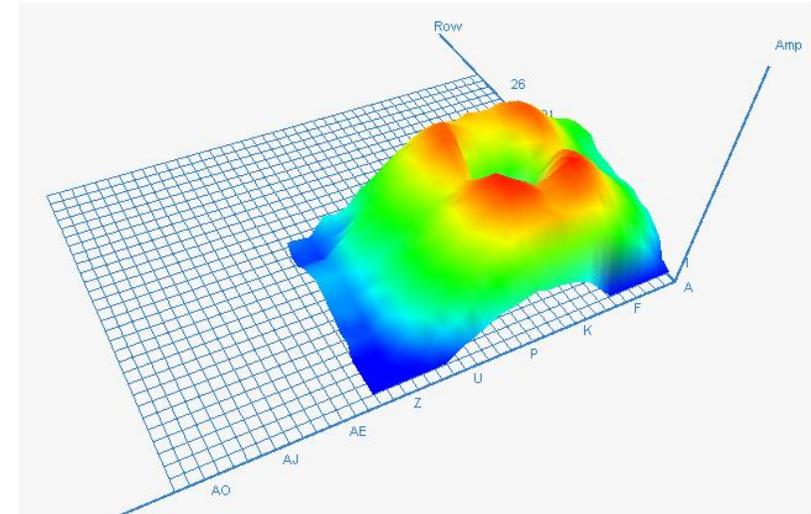
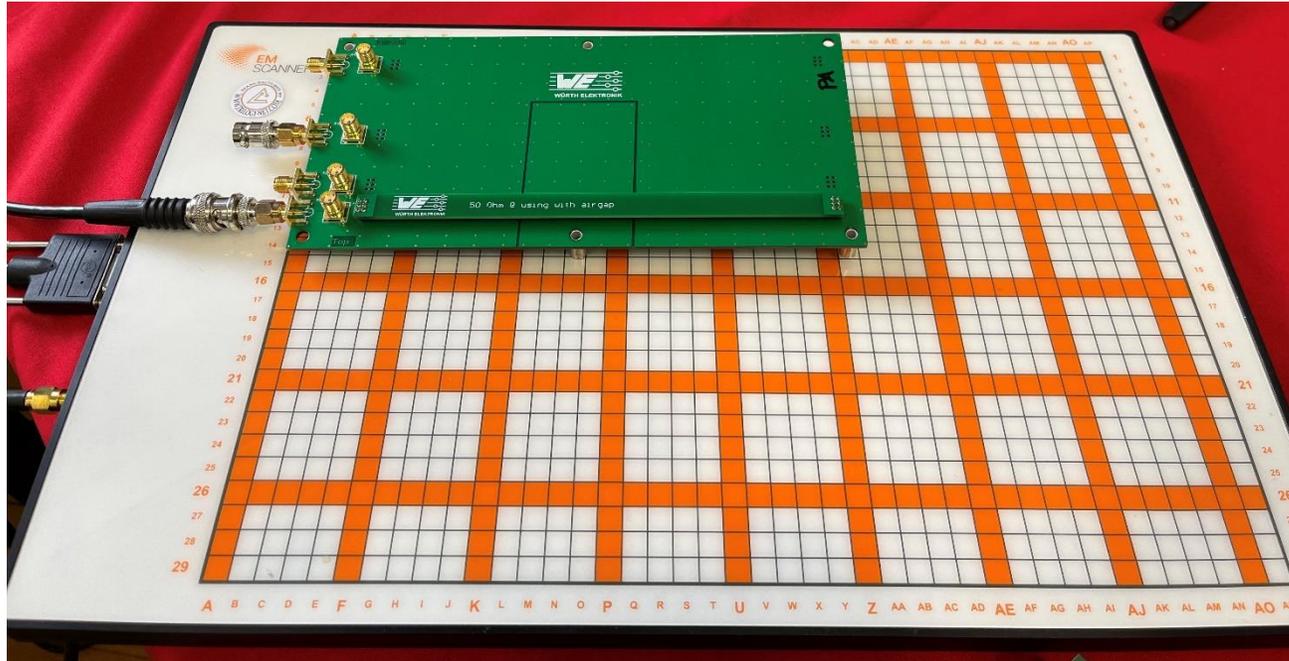
# Coupling effects

Near field measurement



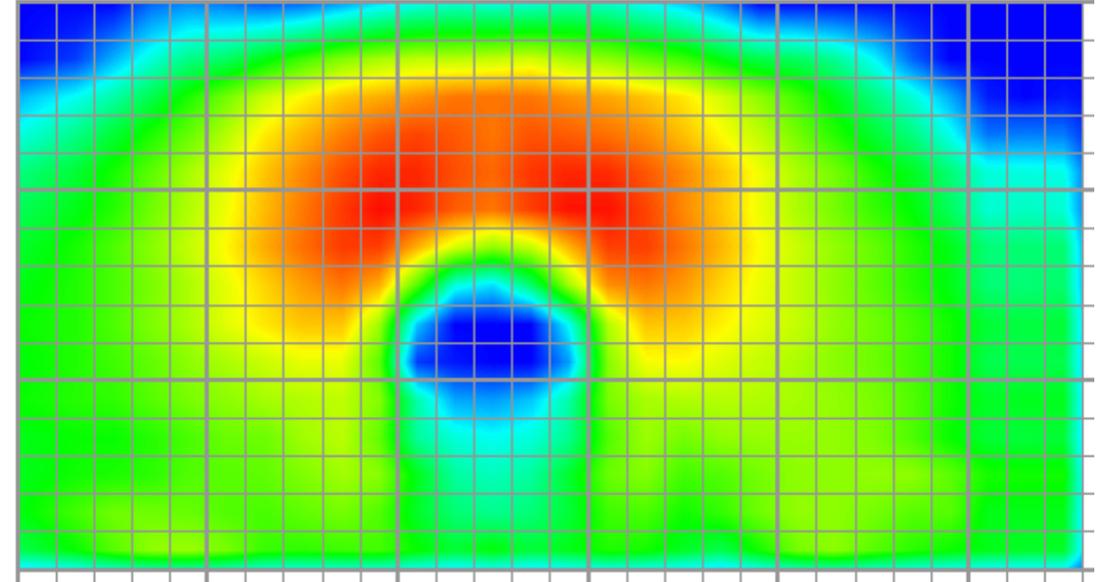
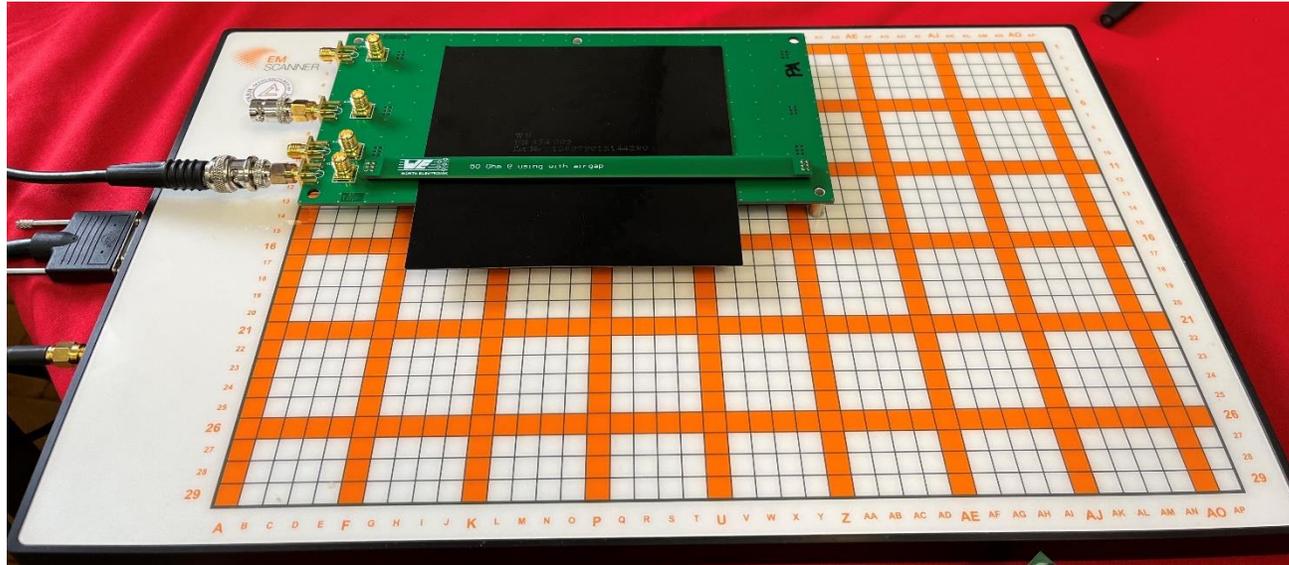
# Coupling effects

Near field measurement



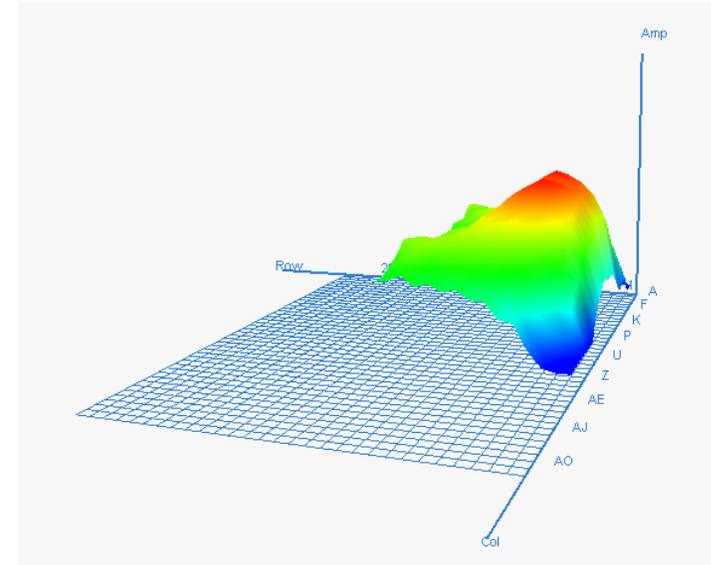
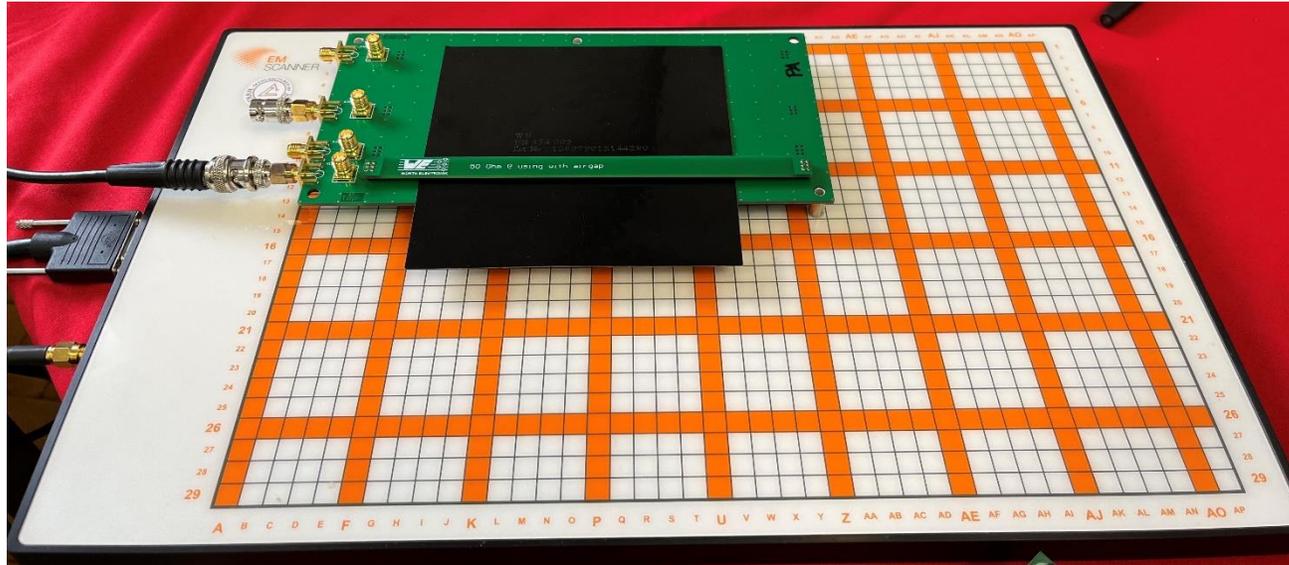
# Coupling effects

Near field measurement with ferrite shielding between signal and GND



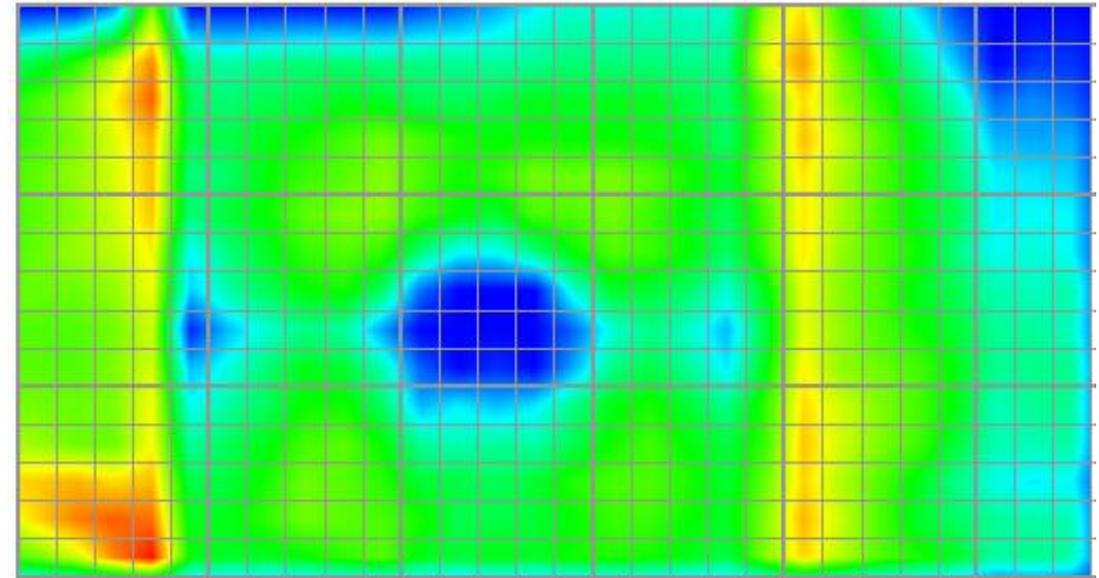
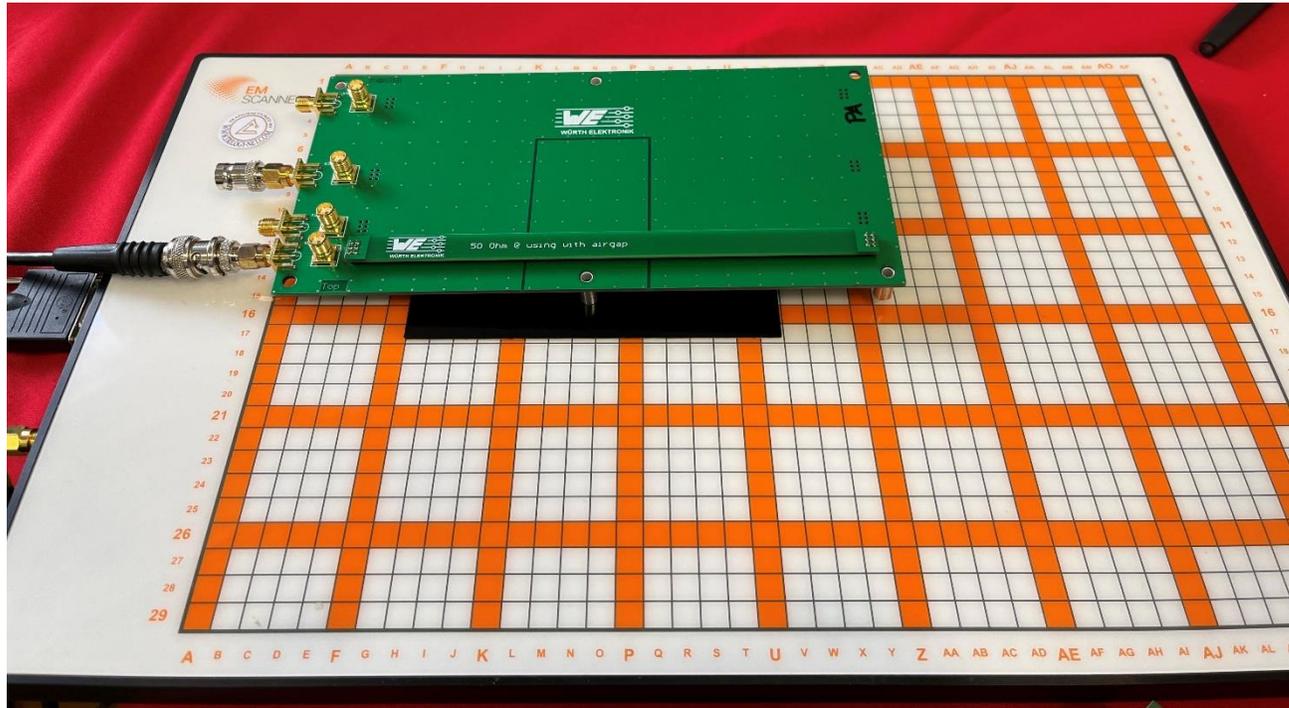
# Coupling effects

Near field measurement



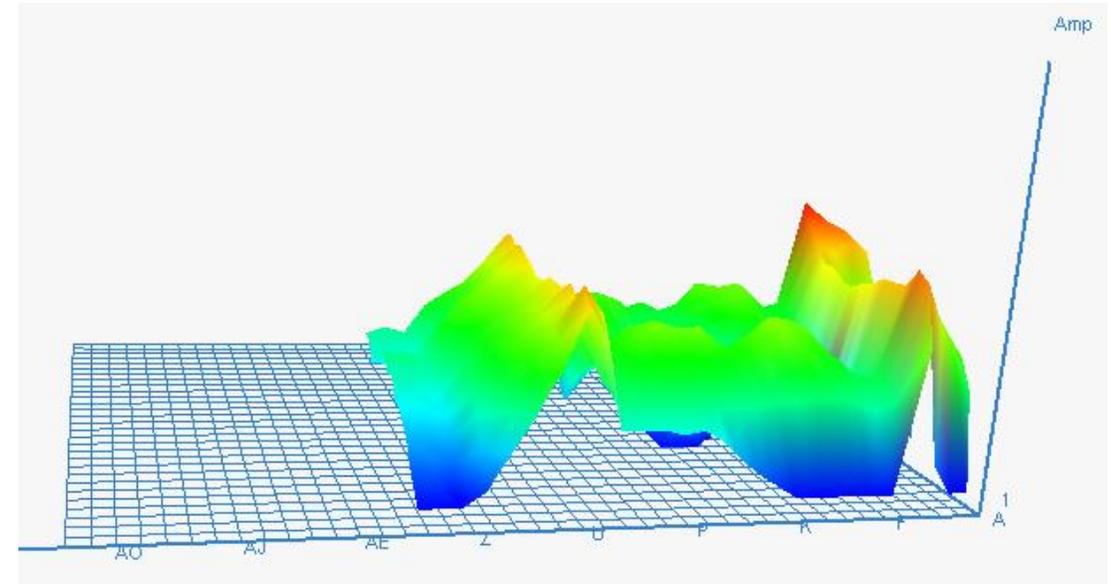
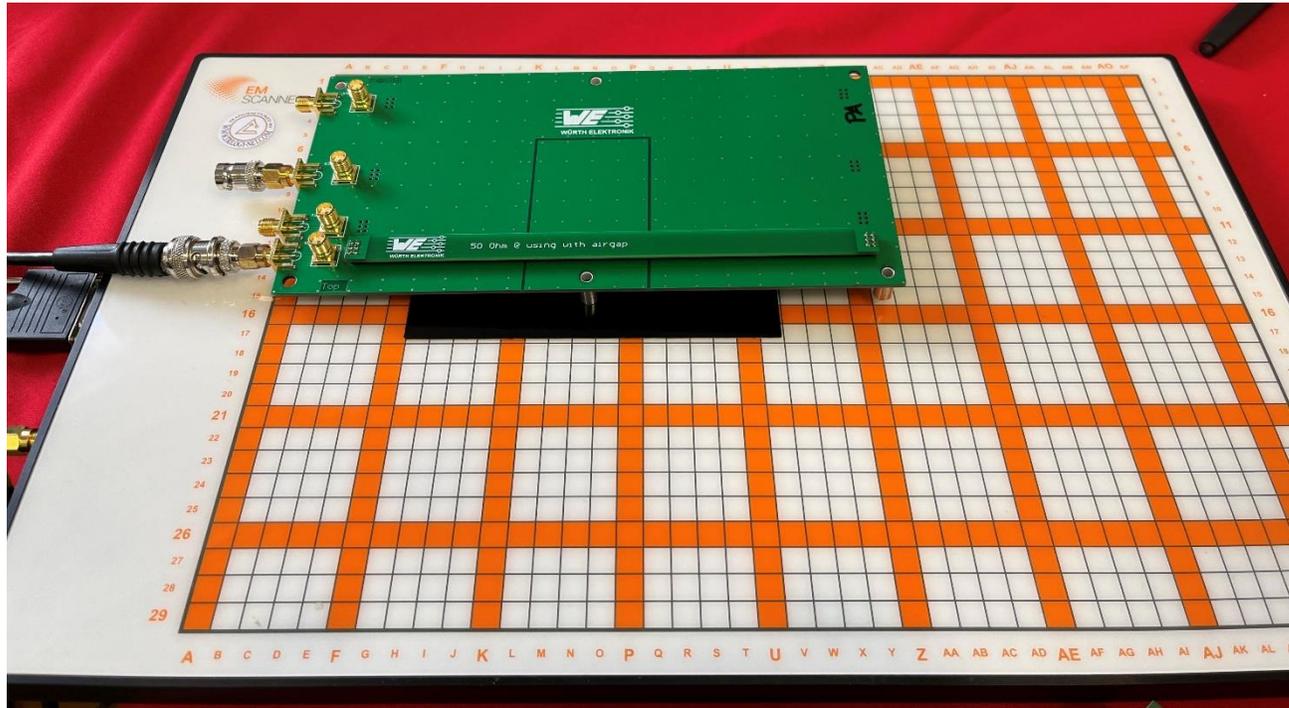
# Coupling effects

Near field measurement with ferrite shielding between GND and the near field probe

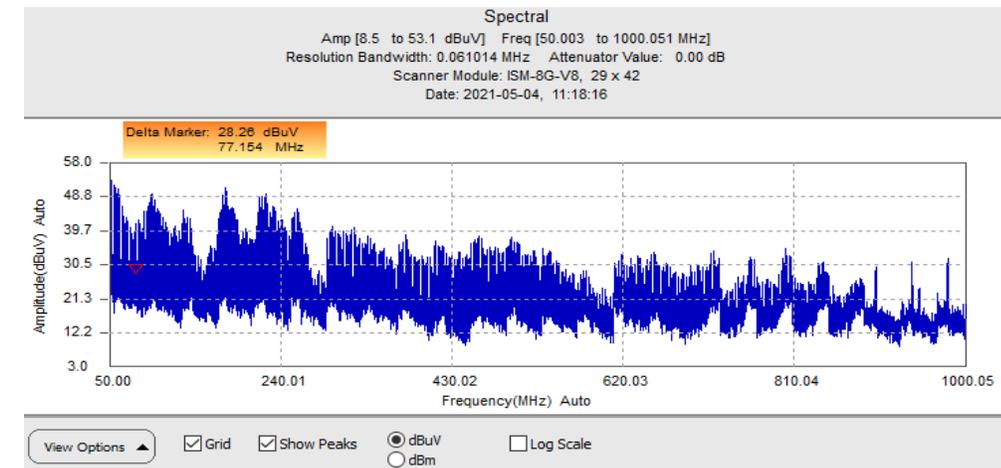
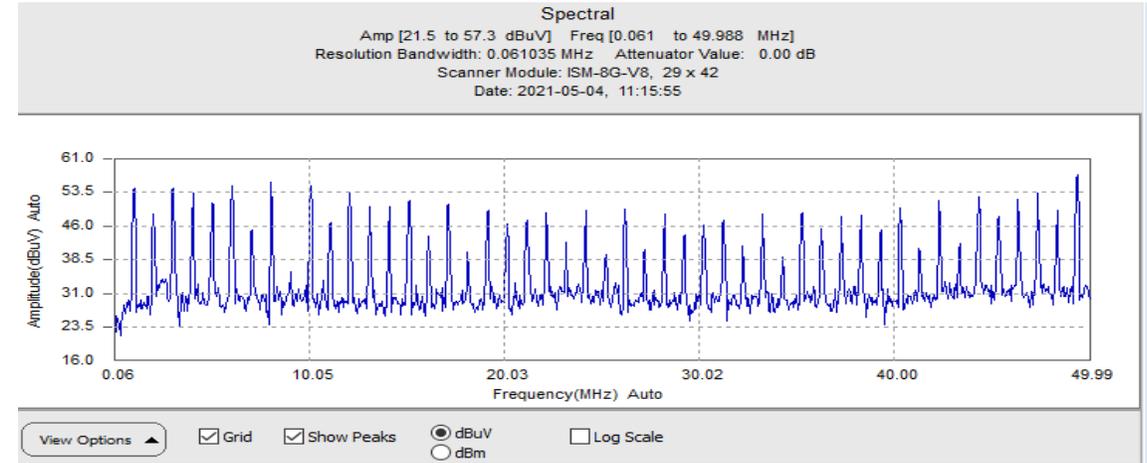
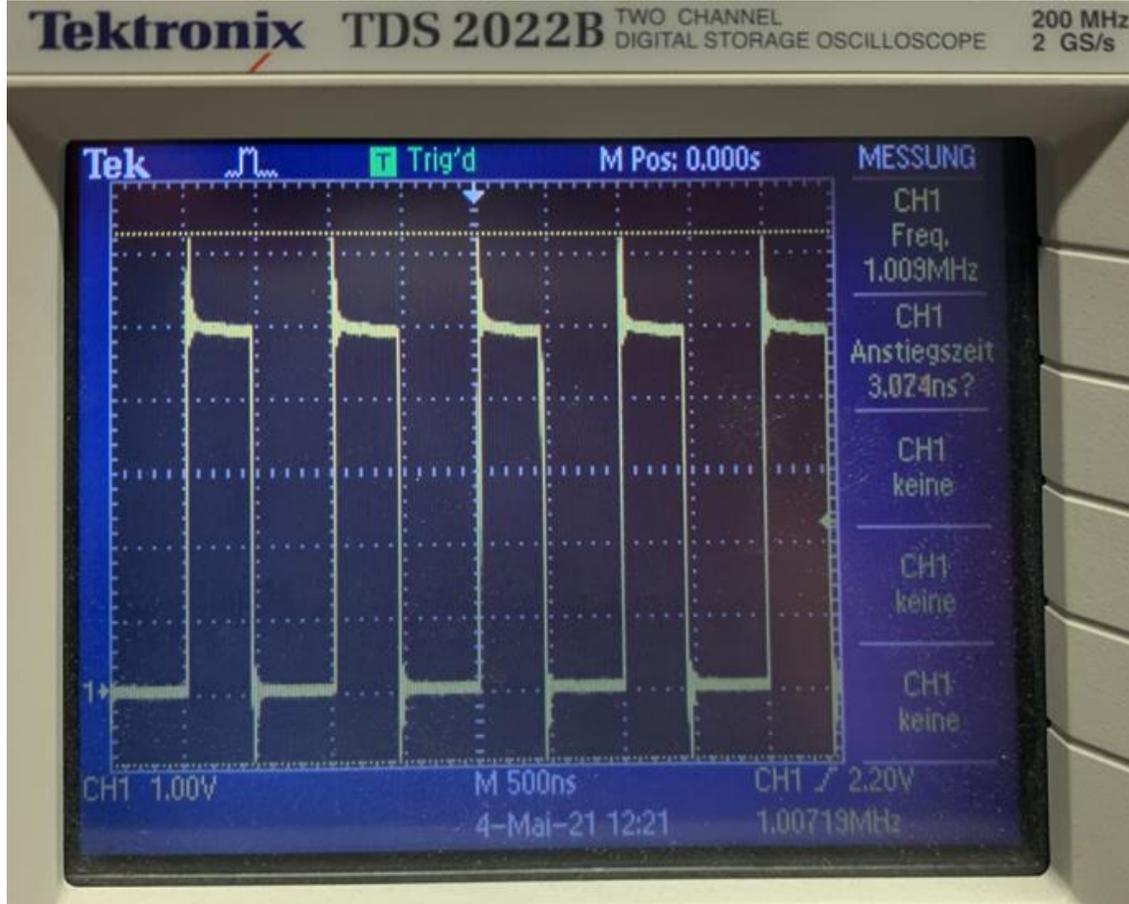


# Coupling effects

Near field measurement with ferrite shielding between GND and the near field probe



# Messung mit dem EMScan



# Coupling effects

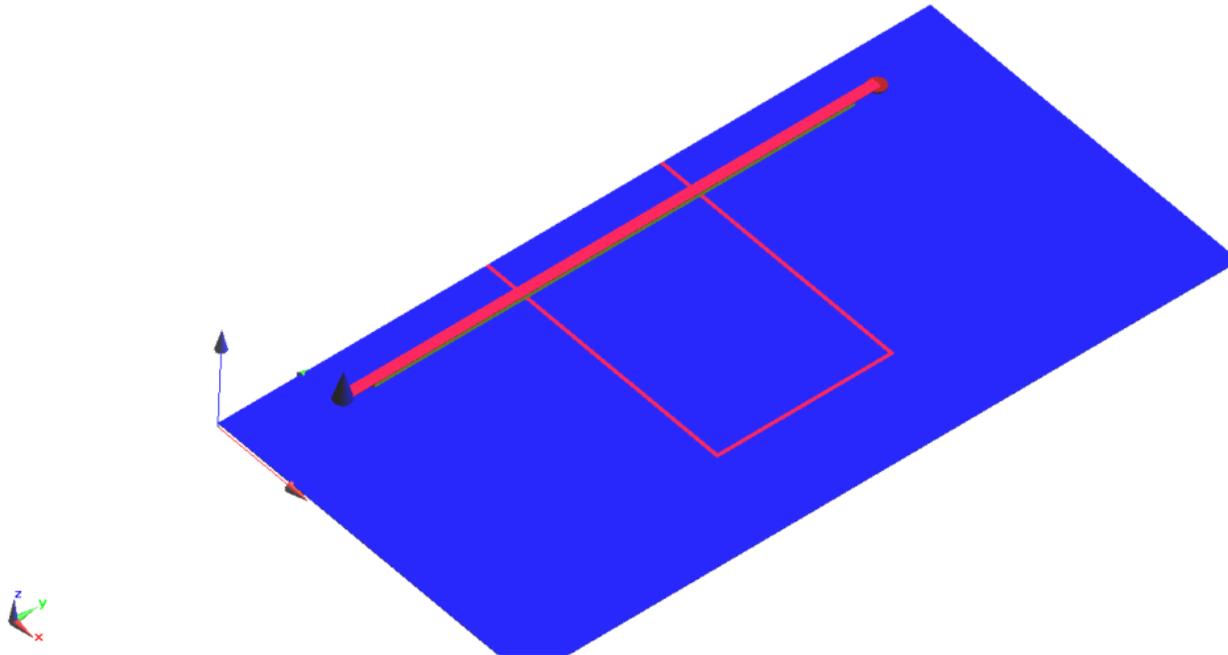
Simulation

## **Simulationsoftware:**

Sim4Life = FDTD-Simulationstool (FDTD=Finite Differences in Time Domain)

Swiss company ZMT (= Zurich Med tech)

## **Model:**



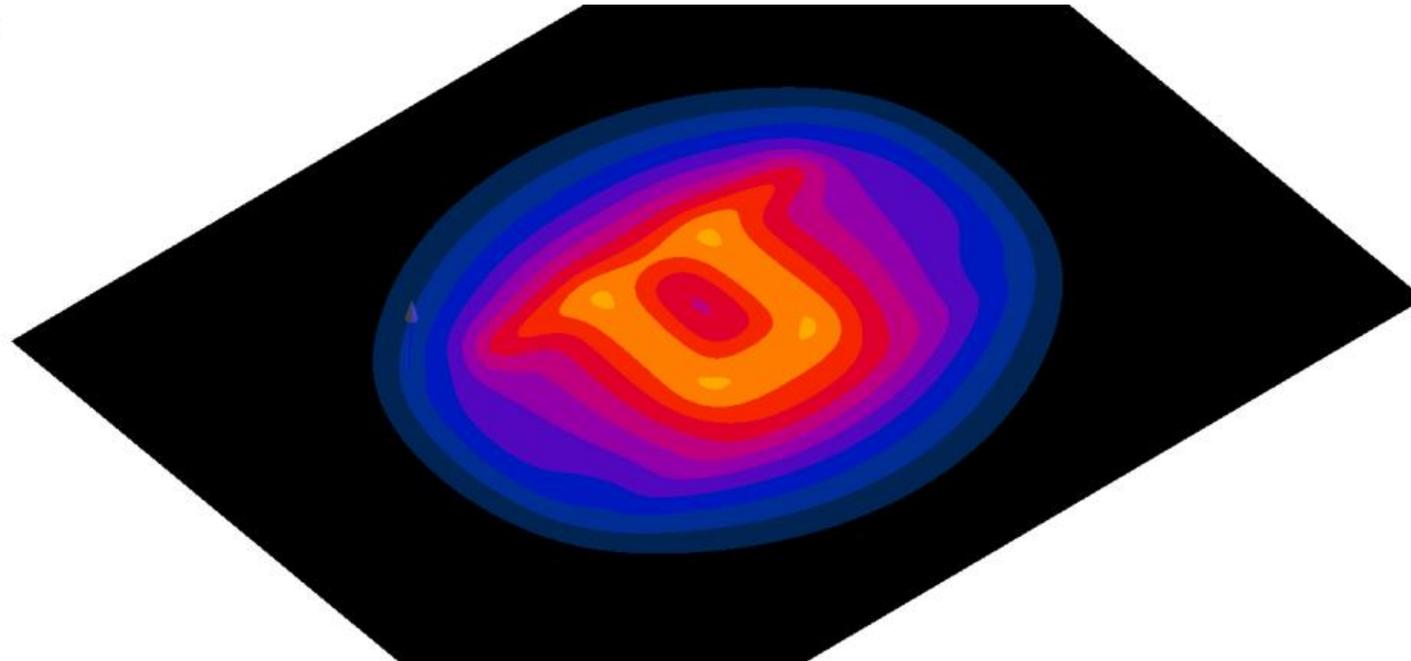
# Coupling effects

Simulation

## Magnetic-field simulation:

1cm under the prin (identical to the near field measurement with the EMScan)

H(x,y,z,f) in dB, at 0.025GHz

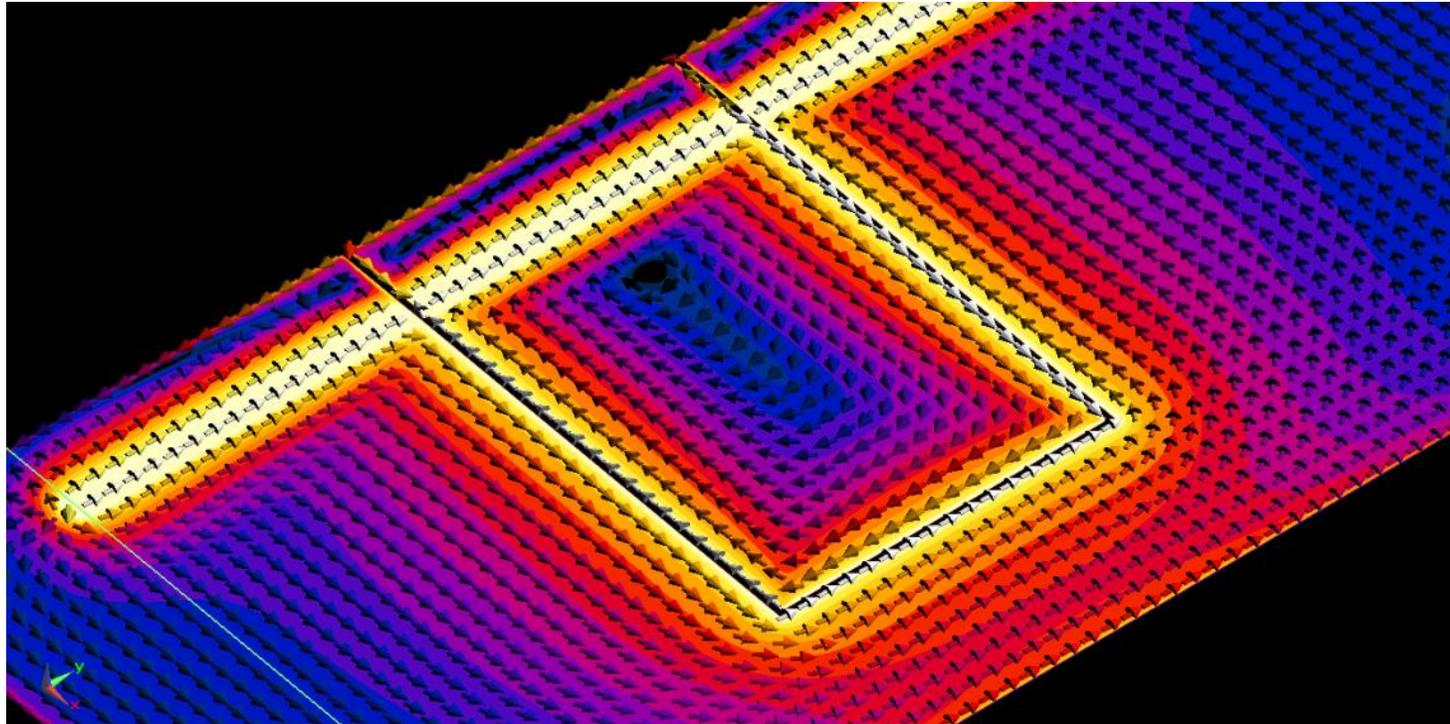


# Coupling effects

Simulation

## Current path:

On the GND layer



# Schirmanbindung

Pfade hochfrequenter Ströme

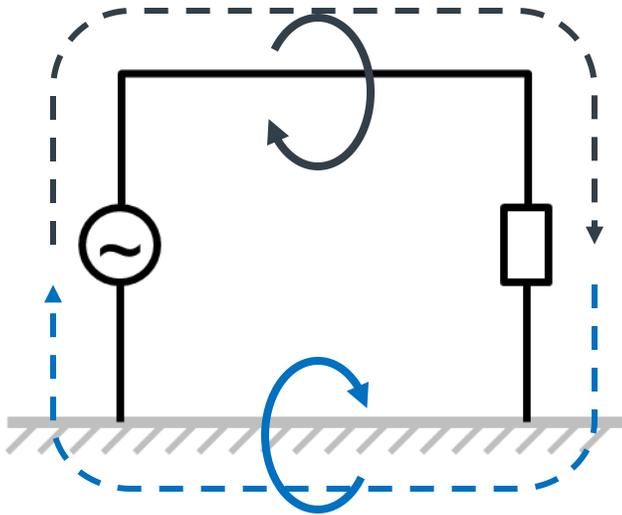
Impedanz des Rückstrompfades

Messungen des Magnetfeldes der Leiterschleife

# Shielding

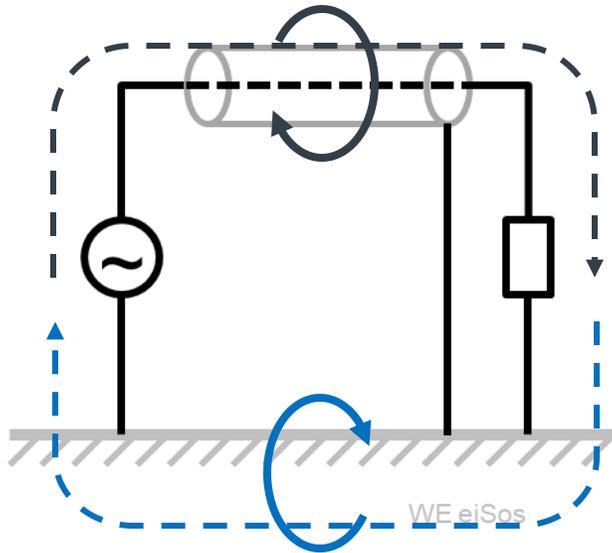
## Cable shielding

RADIATED NOISE



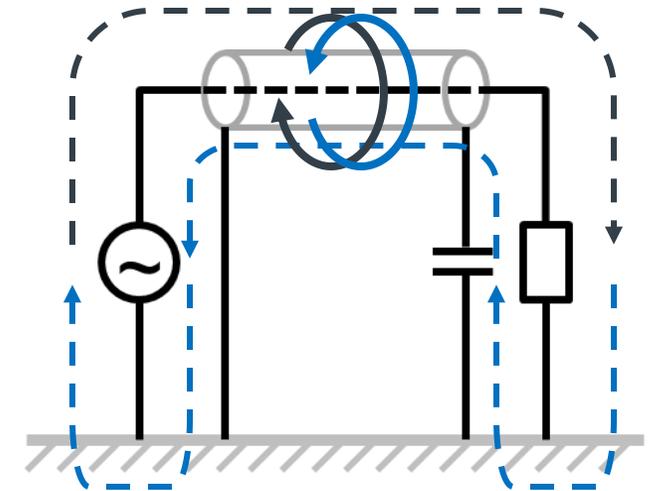
Without shielding, big enclosed current loop surface

Shielded E-field  
uncompensated H-field



Added shielding, **one** end grounded,  
big current loop surface

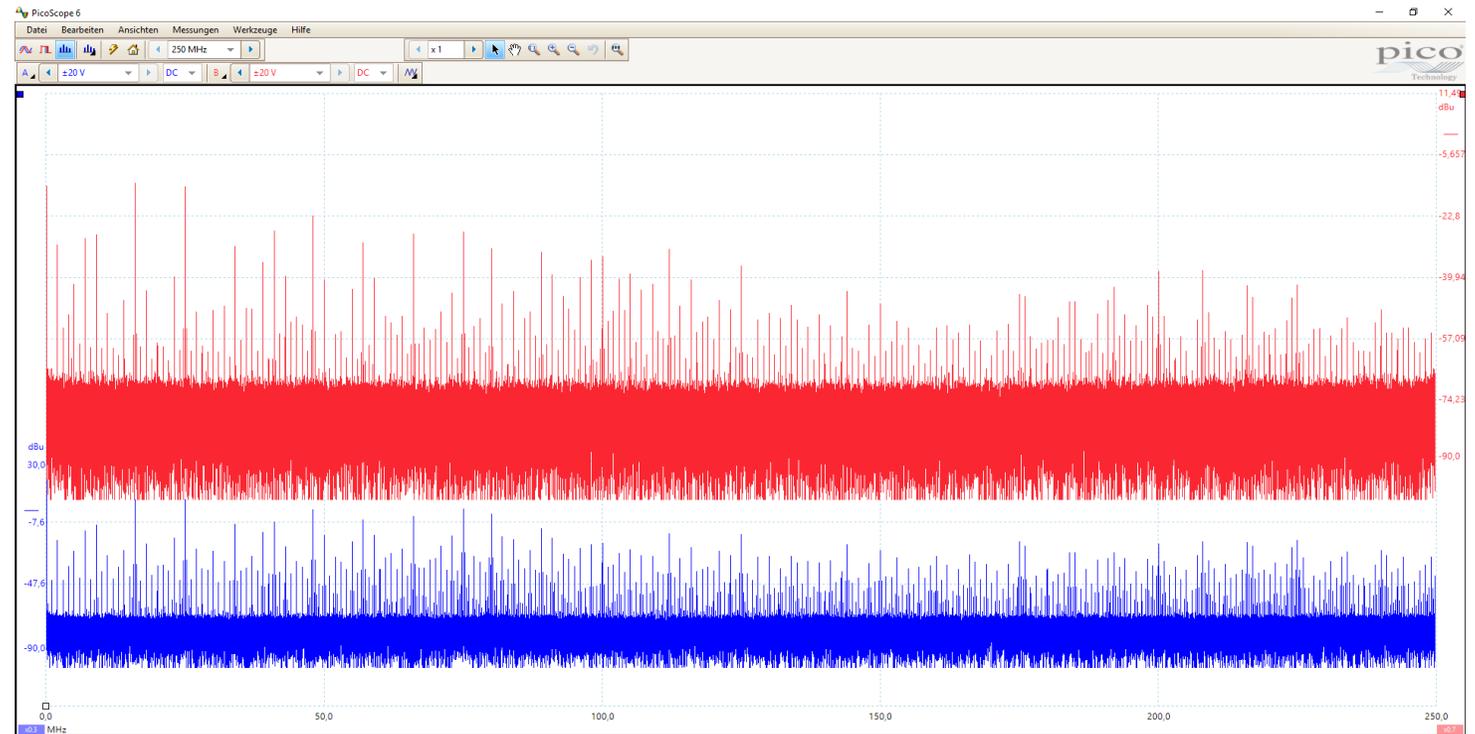
Shielded E-field  
compensated H-field



Added shielding, **both** ends grounded,  
**reduced** current loop surface

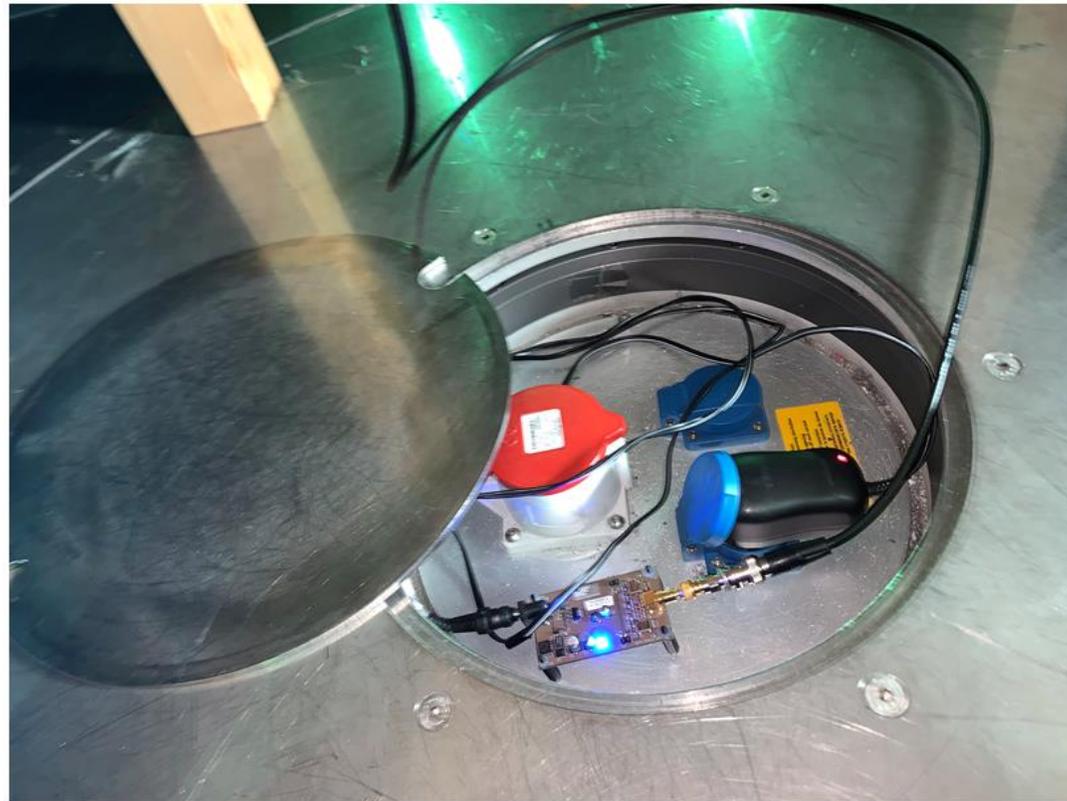
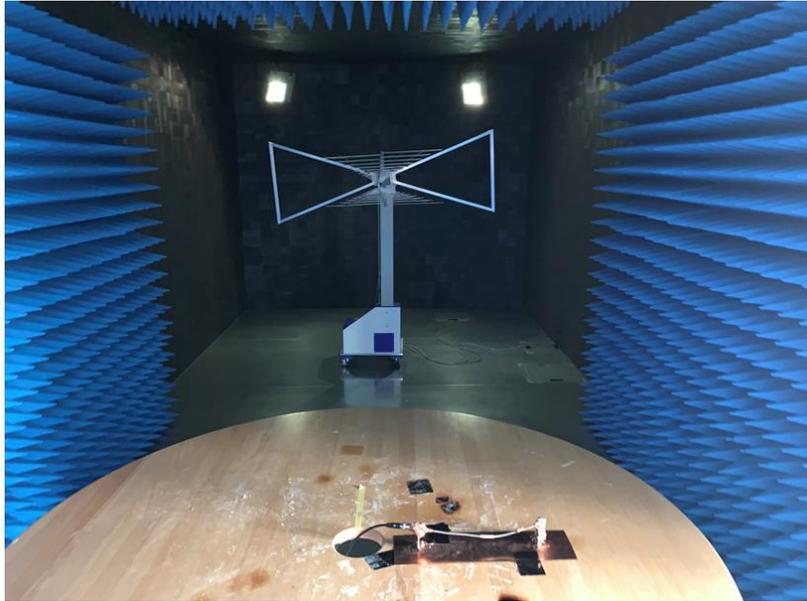
# Shielding

How should you attach the shielding?



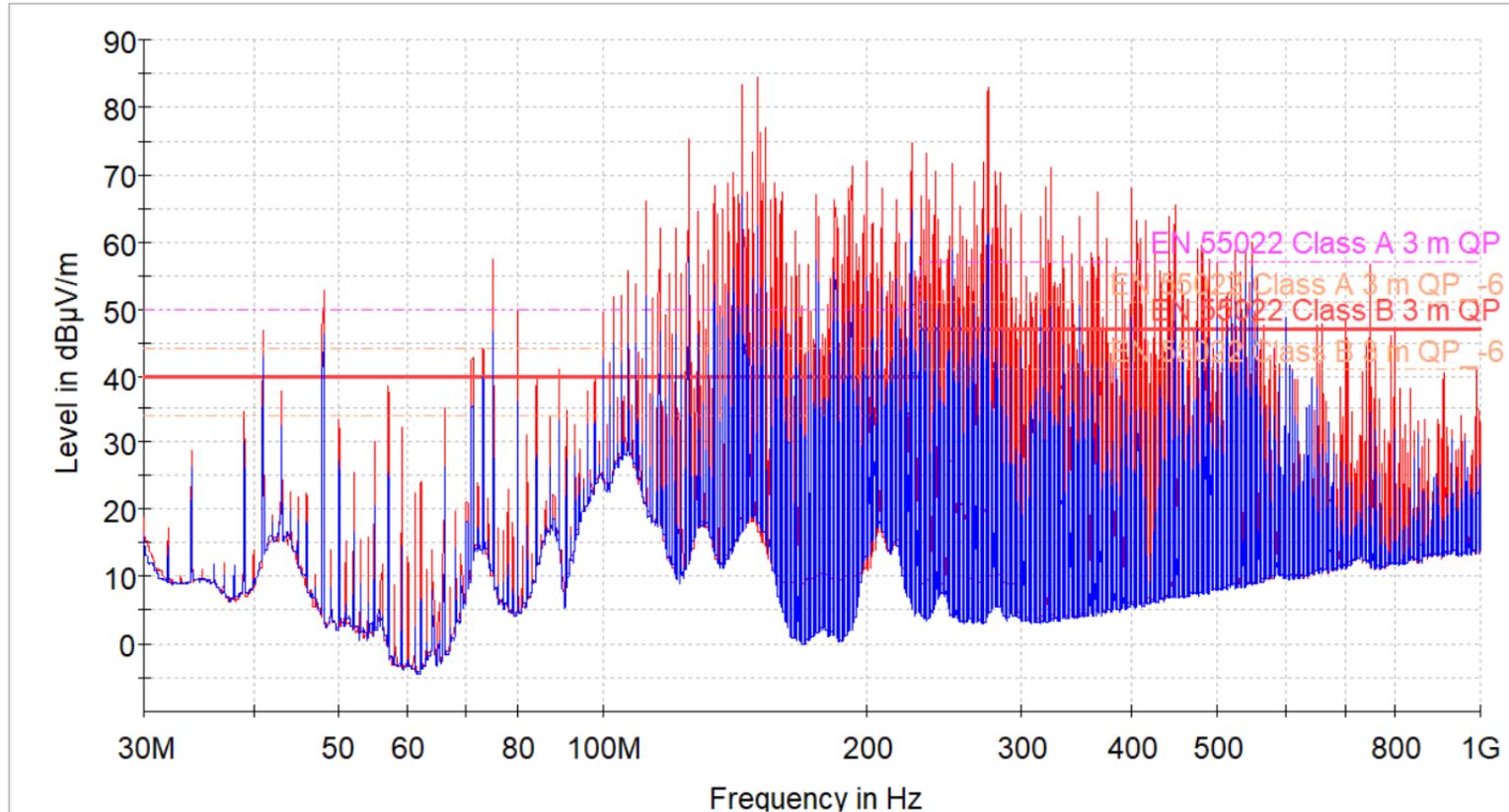
# Shielding

E – field measurements in the emc chamber



# Shielding

E – field measurements in the emc chamber

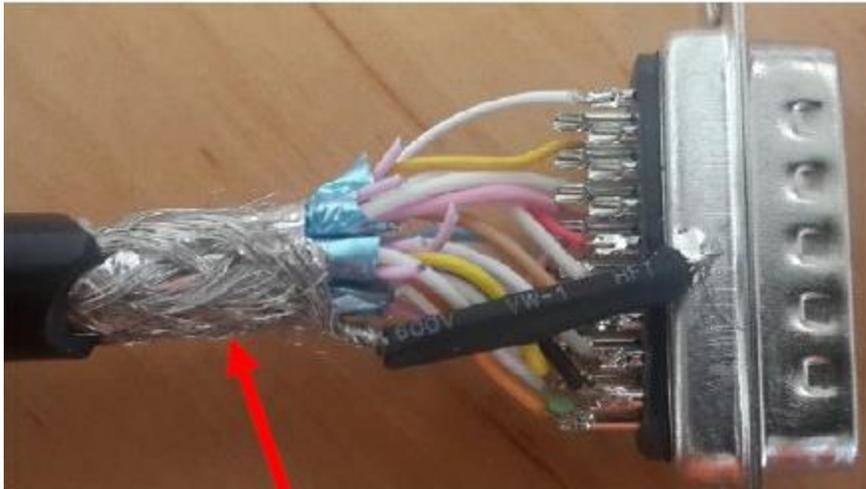


- große Leiterschleife QPK\_CLRWR
- EN 55022 Class A 3 m QP
- EN 55022 Class A 3 m QP -6
- EN 55022 Class B 3 m QP
- EN 55022 Class B 3 m QP -6
- kleine Leiterschleife QPK\_CLRWR

# Shielding

## Cable shielding examples

Area coverage of the braided shielding > 85%



Every twisted pair should be shielded separately



